SEARCH REQUEST FORM

Scientific and Technical Information Center

Requester's Full Name: *JACQUES VEILLARD* Examiner # : *77600* Date: *2-18-04*
Art Unit: *2175*   Phone Number 30*5-7094*   Serial Number: *C91750,317*
Mail Box and Bldg/Room Location: *4804*   Results Format Preferred (circle): (PAPER) DISK E-MAIL

If more than one search is submitted, please prioritize searches in order of need.
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Please provide a detailed statement of the search topic, and describe as specifically as possible the subject matter to be searched. Include the elected species or structures, keywords, synonyms, acronyms, and registry numbers, and combine with the concept or utility of the invention. Define any terms that may have a special meaning. Give examples or relevant citations, authors, etc, if known. Please attach a copy of the cover sheet, pertinent claims, and abstract.

Title of Invention: *System and Method for Enabling Statistical Matching*

Inventors (please provide full names): *Robert Walter Schreiber*

Earliest Priority Filing Date: *12-29-2000*

For Sequence Searches Only Please include all pertinent information (parent, child, divisional, or issued patent numbers) along with the appropriate serial number. → *60/209,644 6/5/2000 -*

Please focus on: request for data; Predetermine tolerance adjunits;
hierarchical data list;
first statistical curve.
Second statistical curve, and
Overlap amount of the first curve statistical
curve and second statistical curve.
                                                           attached
For better understanding see the copy of the undocumented
claims thanks. -

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STAFF USE ONLY

	Type of Search	Vendors and cost where applicable
Searcher:	NA Sequence (#)	STN
Searcher Phone #:	AA Sequence (#)	Dialog
Searcher Location:	Structure (#)	Questel/Orbit
Date Searcher Picked Up:	Bibliographic	Dr.Link
Date Completed:	Litigation	Lexis/Nexis
Searcher Prep & Review Time:	Fulltext	Sequence Systems
Clerical Prep Time:	Patent Family	WWW/Internet
Online Time:	Other	Other (specify)

PTO-1590 (8-01)

STIC Search Results
Feedback Form

USPTO

EIC 2100

Questions about the scope or the results of the search? Contact *the EIC searcher or contact*:

Anne Hendrickson, EIC 2100 Team Leader
308-7831, CPK2-4B40

Voluntary Results Feedback Form

➢ *I am an examiner in Workgroup:* [   ]   *Example: 2133*

➢ *Relevant prior art **found**, search results used as follows:*

- ☐ 102 rejection
- ☐ 103 rejection
- ☐ Cited as being of interest.
- ☐ Helped examiner better understand the invention.
- ☐ Helped examiner better understand the state of the art in their technology.

Types of relevant prior art found:

- ☐ Foreign Patent(s)
- ☐ Non-Patent Literature
   (journal articles, conference proceedings, new product announcements etc.)

➢ *Relevant prior art **not found**:*

- ☐ Results verified the lack of relevant prior art (helped determine patentability).
- ☐ Results were not useful in determining patentability or understanding the invention.

Comments:

Drop off or send completed forms to STIC/EIC2100 CPK2-4B40

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